

Notice of References Cited	Application/Control No. 10/590,663		Applicant(s)/Patent Under Reexamination KOBAYASHI, HIDEO	
	Examiner Sylvia R. MacArthur		Art Unit 1716	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,332,055	02-2008	Orii et al.	156/345.17
*	B	US-6,793,769	09-2004	Kajino et al.	156/345.55
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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